

Single P-Channel MOSFET

■ DESCRIPTION

The SMC4869NA uses trench MOSFET technology. Provides extremely low $R_{DS(ON)}$, Low resistance package and excellent fast switching performance. This device is ideal for efficient and fast switching applications.

■ PART NUMBER INFORMATION

SMC 4869 NA - TR G

a	b	c	d	e
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a : Company name.

b : Product Serial number.

c : Package code NA:DFN3.3X3.3A-8

d : Handling code TR:Tape&Reel

e : Green produce code G:RoHS Compliant

■ FEATURES

$V_{DS}=-30V$, $I_D=-30A$

$R_{DS(ON)}=16m\Omega$ (Typ.)@ $V_{GS}=-10V$

$R_{DS(ON)}=24m\Omega$ (Typ.)@ $V_{GS}=-4.5V$

◆100% EAS Guarantee

◆High power and current handling capability

■ APPLICATIONS

◆Power Management

◆DC/DC Converters



DFN3.3X3.3A-8

■ ABSOLUTE MAXIMUM RATINGS ($T_A=25^\circ C$ Unless otherwise noted)

Symbol	Parameter	Rating	Units
V_{DSS}	Drain-Source Voltage	-30	V
V_{GSS}	Gate-Source Voltage	± 25	V
I_D	Continuous Drain Current	$T_c=25^\circ C$	A
		$T_c=100^\circ C$	A
I_{DM}	Pulsed Drain Current ^B	-120	A
I_D	Continuous Drain Current	$T_A=25^\circ C$	A
		$T_A=70^\circ C$	A
P_D	Power Dissipation ^A	$T_A=25^\circ C$	W
		$T_A=70^\circ C$	W
I_{AS}	Avalanche Current ^A	-25	A
E_{AS}	Single Pulse Avalanche energy $L=0.1mH$ ^B	31.3	mJ
P_D	Power Dissipation ^C	$T_c=25^\circ C$	W
		$T_c=100^\circ C$	W
T_J	Operation Junction Temperature	-55/150	°C
T_{STG}	Storage Temperature Range	-55/150	°C

■ THERMAL RESISTANCE

Symbol	Parameter	Typ	Max	Units
$R_{\theta JA}$	Thermal Resistance Junction to Ambient ^A	$t \leq 10s$	35	°C/W
	Thermal Resistance Junction to Ambient ^{AC}		65	
$R_{\theta JC}$	Thermal Resistance Junction to Case	Steady-State	4.4	

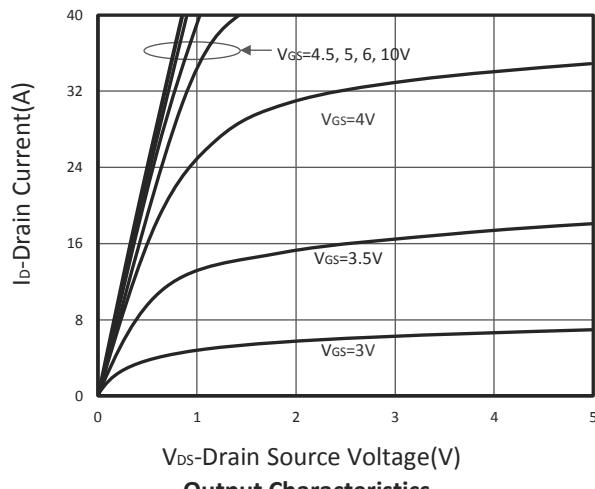
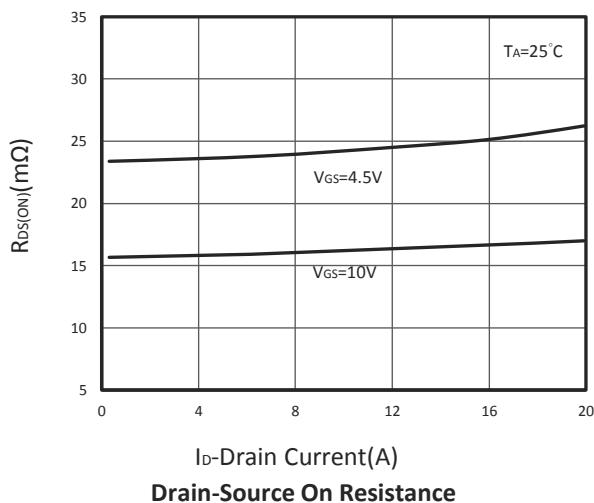
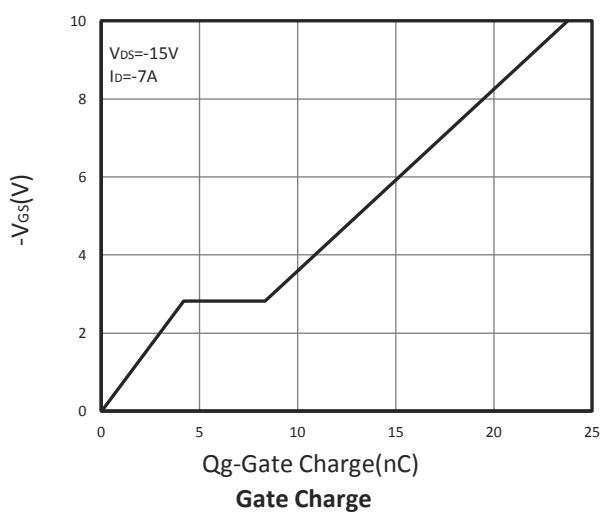
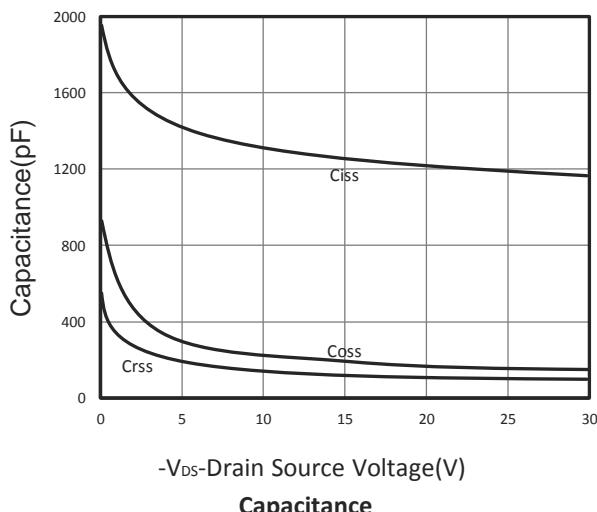
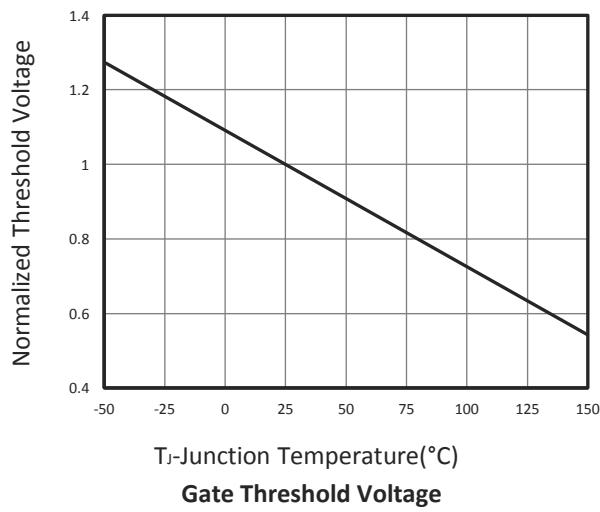
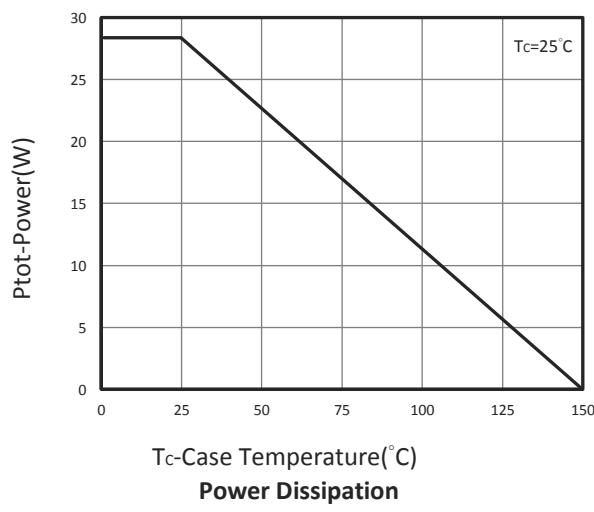
ELECTRICAL CHARACTERISTICS($T_A=25^\circ\text{C}$ Unless otherwise noted)

Symbol	Parameter	Condition	Min	Typ	Max	Unit	
Static Parameters							
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{GS}=0\text{V}$, $I_D=-250\mu\text{A}$	-30			V	
$V_{GS(\text{th})}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_D=-250\mu\text{A}$	-1	-1.6	-2.5	V	
I_{GSS}	Gate Leakage Current	$V_{DS}=0\text{V}$, $V_{GS}=\pm 20\text{V}$			± 100	nA	
I_{DSS}	Zero Gate Voltage Drain Current	$V_{DS}=-30\text{V}$, $V_{GS}=0\text{V}$, $T_J=25^\circ\text{C}$			-1	μA	
		$V_{DS}=-24\text{V}$, $V_{GS}=0\text{V}$, $T_J=75^\circ\text{C}$			-10		
$R_{DS(\text{ON})}$	Drain-source On-Resistance ^D	$V_{GS}=-10\text{V}$, $I_D=-10.6\text{A}$		16	20	$\text{m}\Omega$	
		$V_{GS}=-4.5\text{V}$, $I_D=-8\text{A}$		24	29		
G_f	Forward Transconductance	$V_{DS}=-10\text{V}$, $I_D=-7\text{A}$		12.5		S	
Diode Characteristics							
V_{SD}	Diode Forward Voltage ^D	$I_S=-1\text{A}$, $V_{GS}=0\text{V}$			-1	V	
I_S	Diode Continuous Forward Current				-30	A	
t_{rr}	Reverse Recovery Time	$I_S=-7\text{A}$, $dI/dt=100\text{A}/\mu\text{s}$		11		ns	
Q_{rr}	Reverse Recovery Charge			5.8		nC	
Dynamic and Switching Parameters^E							
Q_g	Total Gate Charge	$V_{DS}=-15\text{V}$, $V_{GS}=-10\text{V}$, $I_D=-7\text{A}$		23.6	33	nC	
Q_g	Total Gate Charge (4.5V)			11.5	16.1		
Q_{gs}	Gate-Source Charge			4.2	5.9		
Q_{gd}	Gate-Drain Charge			4.4	6.2		
C_{iss}	Input Capacitance	$V_{DS}=-15\text{V}$, $V_{GS}=0\text{V}$, $f=1\text{MHz}$		1280		pF	
C_{oss}	Output Capacitance			175			
C_{rss}	Reverse Transfer Capacitance			125			
$t_{d(on)}$	Turn-On Time	$V_{DD}=-15\text{V}$, $V_{GEN}=-10\text{V}$ $R_G=3.3\Omega$, $I_D=-1\text{A}$		6.1	12	nS	
t_r				14	27		
$t_{d(off)}$	Turn-Off Time			34	65		
t_f				13.2	25		

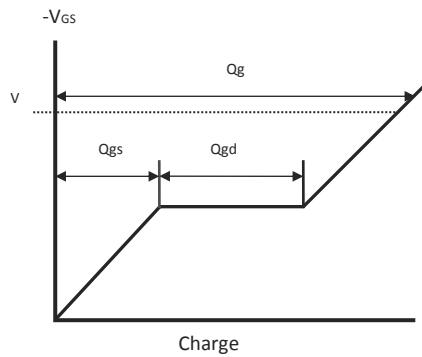
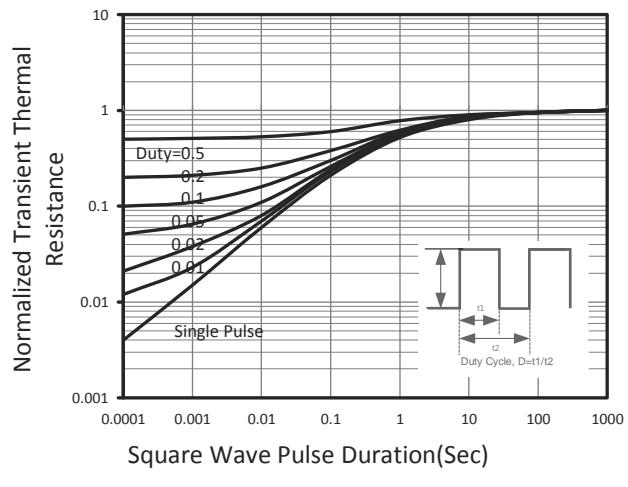
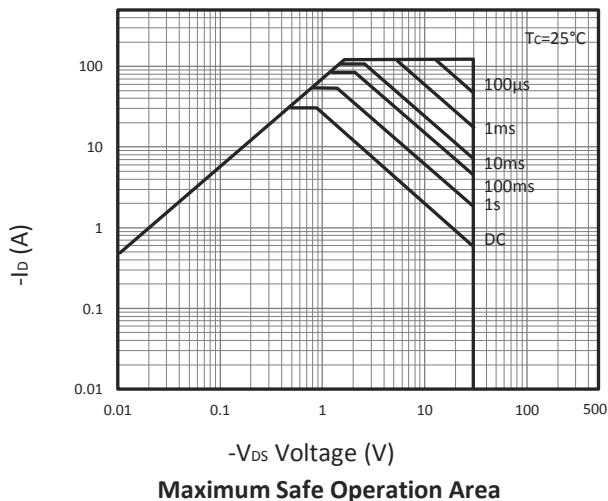
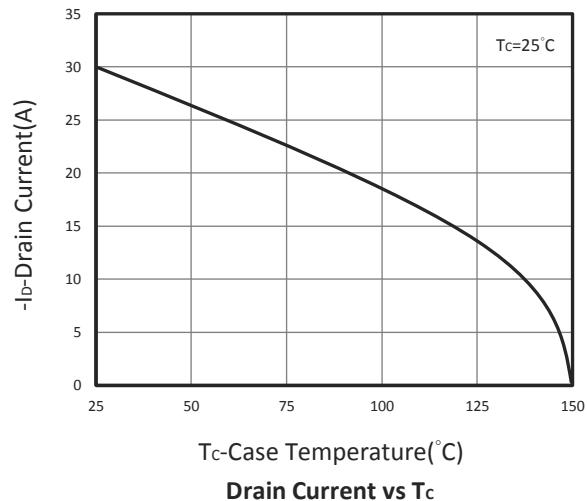
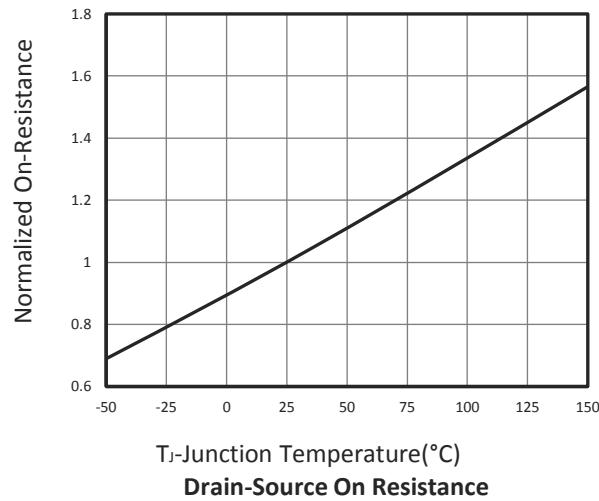
Note: Absolute maximum ratings are those values beyond which the device could be permanently damaged.

- A. Surface mounted on FR4 board using 1 in² pad size.
- B. Pulsed width limited by maximum junction temperature, $T_{J(\text{MAX})}=150^\circ\text{C}$ (initial temperature $T_J=25^\circ\text{C}$).
- C. Using $\leq 10\text{s}$ junction-to-ambient thermal resistance is base on $T_{J(\text{MAX})}=150^\circ\text{C}$.
- D. Pulse test width $\leq 300\mu\text{s}$ and duty cycle $\leq 2\%$.
- E. Guaranteed by design, not subject to production testing.

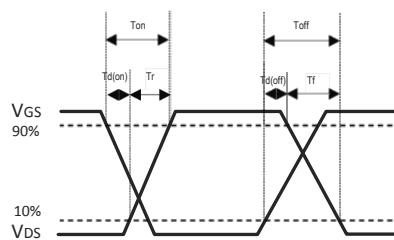
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TYPICAL CHARACTERISTICS

Output Characteristics

Drain-Source On Resistance

Gate Charge

Capacitance

Gate Threshold Voltage

Power Dissipation

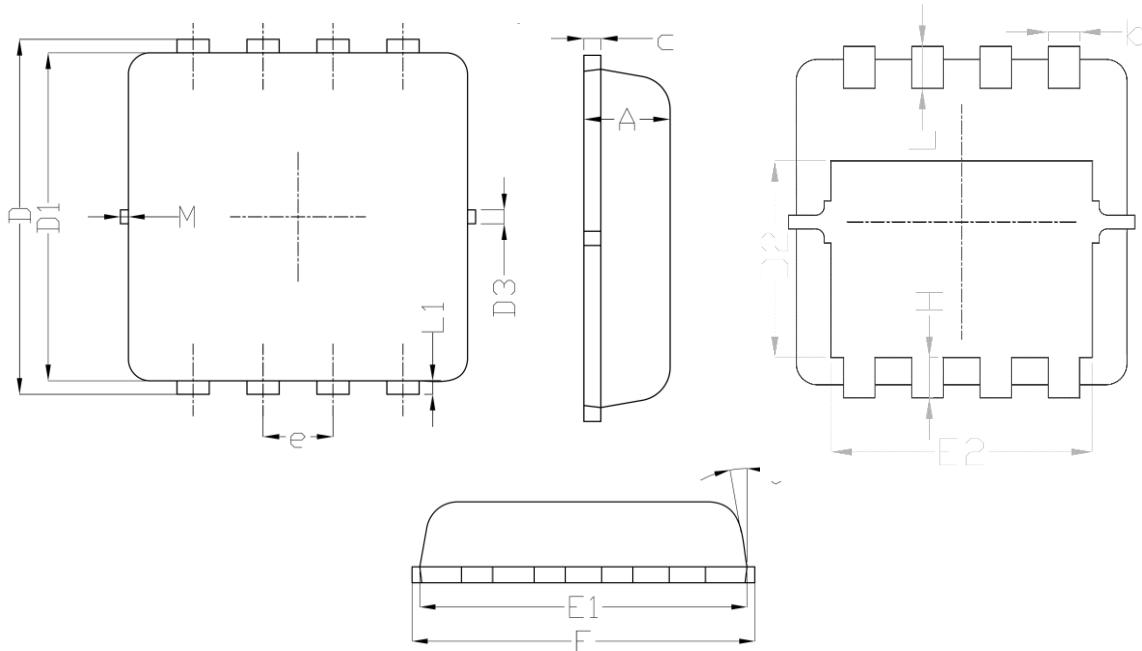
TYPICAL CHARACTERISTICS



Gate Charge Waveform



Switching Time Waveform

■ DFN3.3X3.3A-8 PACKAGE DIMENSIONS


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min.	Max.	Min.	Max.
A	0.700	0.800	0.028	0.031
b	0.250	0.350	0.010	0.014
c	0.100	0.250	0.004	0.010
D	3.250	3.450	0.128	0.136
D1	3.000	3.200	0.118	0.126
D2	1.780	1.980	0.070	0.078
D3	-	0.130	-	0.005
E	3.200	3.400	0.126	0.134
E1	3.000	3.200	0.118	0.126
E2	2.390	2.590	0.094	0.102
e	0.65BSC.		0.026BSC.	
H	0.300	0.500	0.012	0.020
L	0.300	0.500	0.012	0.020
L1	-	0.130	-	0.005
M	-	0.150	-	0.006
θ	0°	12°	0°	12°

Recommended Land Pattern

